

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/791,724	CHEN, YUETING
	Examiner Hwei-Siu C. Payer	Art Unit 3724

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<i>See Interference Search</i> <i>History Printout 1-9-06 Page</i>			